

# FCC RF Test Report

APPLICANT	: Motorola Mobility LLC
EQUIPMENT	: Mobile Cellular Phone
BRAND NAME	: Motorola
MODEL NAME	: XT2343-1
FCC ID	: IHDT56AM4
STANDARD	:47 CFR Part 2, Part 27 Subpart Q
CLASSIFICATION	: PCS Licensed Transmitter Held to Ear (PCE)
TEST DATE(S)	: Jun. 25, 2023 ~ Jun. 28, 2023

We, Sporton International Inc. (Kunshan), would like to declare that the tested sample has been evaluated in accordance with the procedures given in ANSI C63.26-2015 and shown compliance with the applicable technical standards.

The test results in this report apply exclusively to the tested model / sample. Without written approval of Sporton International Inc. (Kunshan), the test report shall not be reproduced except in full.

JasonJia

Approved by: Jason Jia



**Sporton International Inc. (Kunshan)** No. 1098, Pengxi North Road, Kunshan Economic Development Zone Jiangsu Province 215300 People's Republic of China



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## **REVISION HISTORY**

REPORT NO.	VERSION	DESCRIPTION	ISSUED DATE
FG352916E	Rev. 01	Initial issue of report	Jul. 20, 2023



Report Section	FCC Rule	Description	Limit	Result	Remark			
3.4	§2.1046	Conducted Output Power	_	Report Only	-			
3.5	§27.50 (k)(4)	Peak-to-Average Ratio	<13dB	PASS				
3.6	§27.50 (k)(3)	EIRP	EIRP < 1W (30dBm)	PASS	-			
3.7 §2.1049		Occupied Bandwidth	_	Report Only	-			
3.8	§2.1051	Conducted Band Edge	-13dBm/MHz	PASS				
3.0	§27.53 (n)(2)	Measurement		PASS	-			
3.9	§2.1051	Conducted Spurious Emission	-13dBm/MHz	PASS	-			
	§27.53 (n)(2)							
3.10	§2.1055	Frequency Stability	Within the band	PASS	-			
	§27.54	Temperature & Voltage			Under limit			
	\$2,4052			PASS				
4.4	§2.1053	Radiated Spurious Emission	-13dBm/MHz		47.23 dB at 13962.00			
	§27.53 (n)(2)				MHz			
Conformity Assessment Condition:								
<ol> <li>The test results (PASS/FAIL) with all measurement uncertainty excluded are presented against the regulation limits or in accordance with the requirements stipulated by the applicant/manufacturer who shall bear all the risks of non-compliance that may potentially occur if measurement uncertainty is taken into account.</li> </ol>								
Disclaimer:								

## SUMMARY OF TEST RESULT

The product specifications of the EUT presented in the test report that may affect the test assessments are declared by the manufacturer who shall take full responsibility for the authenticity.



## **1** General Description

### 1.1 Applicant

#### Motorola Mobility LLC

222 W, Merchandise Mart Plaza, Chicago IL 60654 USA

## 1.2 Manufacturer

#### Motorola Mobility LLC

222 W, Merchandise Mart Plaza, Chicago IL 60654 USA

## **1.3 Product Feature of Equipment Under Test**

Product Feature				
Equipment	Mobile Cellular Phone			
Brand Name	Motorola			
Model Name	XT2343-1			
FCC ID	IHDT56AM4			
IMEI Code	Conducted: 352326290031213/352326290031221 Radiation: 352326290030496/352326290030504			
HW Version	DVT2			
SW Version	TTD33.32			
EUT Stage	Identical Prototype			

## **1.4 Product Specification of Equipment Under Test**

Product Feature				
Tx/Rx Frequency	LTE Band 42: 3450 MHz ~ 3550 MHz			
Bandwidth	5MHz / 10MHz / 15MHz / 20MHz			
Maximum Output Power to Antenna	LTE Band 42 : 22.33 dBm			
Antenna Gain	LTE Band 42 : -3.8 dBi			
Type of Modulation	QPSK / 16QAM / 64QAM			

## 1.5 Modification of EUT

No modifications are made to the EUT during all test items.



## **1.6 Specification of Accessory**

Specification of Accessory							
AC Adapter 1 (US)	Brand Name	Motorola(Salcomp)	Model Name	MC-201L			
AC Adapter 1 (EU)	Brand Name	Motorola(Salcomp)	Model Name	MC-202L			
AC Adapter 1 (AR)	Brand Name	Motorola(Salcomp)	Model Name	MC-206L			
AC Adapter 1 (BR)	Brand Name	Motorola(Salcomp)	Model Name	MC-207L			
AC Adapter 1 (CHILE)	Brand Name	Motorola(Salcomp)	Model Name	MC-209L			
AC Adapter 2 (US)	Brand Name	Motorola(AOHAI)	Model Name	MC-201L			
AC Adapter 2 (EU)	Brand Name	Motorola(AOHAI)	Model Name	MC-202L			
AC Adapter 2 (AR)	Brand Name	Motorola(AOHAI)	Model Name	MC-206L			
AC Adapter 3 (BR)	Brand Name	Motorola(Cliptech)	Model Name	MC-207L			
AC Adapter 4 (BR)	Brand Name	Motorola(Chenyang)	Model Name	MC-207L			
Battery 1	Brand Name	Motorola(ATL)	Model Name	PC50			
Battery 2	Brand Name	Motorola (SCUD)	Model Name	PC50			
USB Cable 1	Brand Name	Motorola (WASHIN)	Model Name	S928D92375			
USB Cable 2	Brand Name	Motorola (Saibao)	Model Name	S928D95755			
USB Cable 3	Brand Name	Motorola (ISHENG)	Model Name	SC18D38574			

## **1.7 Maximum EIRP Power and Emission Designator**

LTE Band 42		QPSK		16QAM/64QAM		
BW (MHz)	Frequency Range (MHz)	Maximum EIRP(W)	Emission Designator (99%OBW)	Maximum EIRP(W)	Emission Designator (99%OBW)	
5	3452.5 ~ 3547.5	0.0706	4M50G7D	0.0551	4M48W7D	
10	3455 ~ 3545	0.0693	9M07G7D	0.0557	9M05W7D	
15	3457.5 ~ 3542.5	0.0705	13M5G7D	0.0551	13M4W7D	
20	3460 ~ 3540	0.0713	17M9G7D	0.0562	18M0W7D	



## 1.8 Testing Site

Sporton International Inc. (Kunshan) is accredited to ISO/IEC 17025:2017 by American Association for Laboratory Accreditation with Certificate Number 5145.02.

Test Firm	Sporton International Inc. (Kunshan)				
Test Site Location	No. 1098, Pengxi North Road, Kunshan Economic Development Zone				
Test Sile Location	Jiangsu Province 215300 People's Republic of China TEL : +86-512-57900158				
	On onton Oito No		FCC Test Firm		
Test Site No.	Sporton Site No.	FCC Designation No.	Registration No.		
	03CH04-KS TH01-KS	CN1257	314309		

### 1.9 Test Software

Item Site		Manufacturer	Name	Version
1.	03CH04-KS	AUDIX	E3	6.2009-8-24al

## 1.10 Applied Standards

According to the specifications of the manufacturer, the EUT must comply with the requirements of the following standards:

- 47 CFR Part 2, Part 27 Subpart Q
- ANSI C63.26-2015
- FCC KDB 971168 Power Meas License Digital Systems D01 v03r01
- FCC KDB 412172 D01 Determining ERP and EIRP v01r01

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#### Remark:

- **1.** All test items were verified and recorded according to the standards and without any deviation during the test.
- **2.** This EUT has also been tested and complied with the requirements of FCC Part 15, Subpart B, recorded in a separate test report.



## 2 Test Configuration of Equipment Under Test

## 2.1 Test Mode

Antenna port conducted and radiated test items listed below are performed according to KDB 971168 D01 Power Meas. License Digital Systems v03r01 with maximum output power.

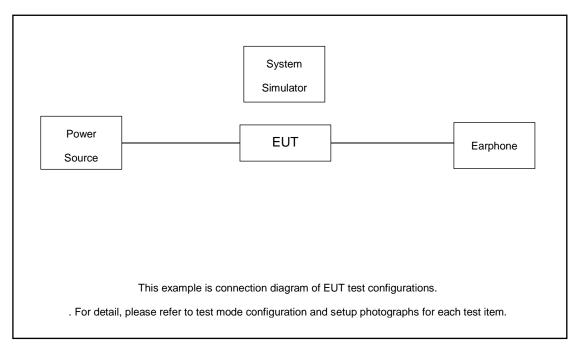
Radiated measurements are performed by rotating the EUT in three different orthogonal test planes to find the maximum emission.

	Bandwidth (MHz) Modulation		RB #	Test Channel
Band	eg. 5M, 10M, 15M, 20M	eg. QPSK, 16QAM, 64QAM	1RB, Partial RB, Full RB	L/M/H
LTE Band 42	5M, 10M, 15M, 20M	QPSK, 16QAM, 64QAM	1RB, Full RB	L, M, H
LTE Band 42	20M	QPSK, 16QAM, 64QAM	Full RB	М
LTE Band 42	5M, 10M, 15M, 20M	QPSK, 16QAM, 64QAM	1RB, Full RB	L, M, H
LTE Band 42	5M, 10M, 15M, 20M	QPSK, 16QAM	Full RB	М
LTE Band 42	5M, 10M, 15M, 20M	QPSK, 16QAM, 64QAM	1RB, Full RB	L, H
LTE Band 42	5M, 10M, 15M, 20M	QPSK	1RB	L, M, H
LTE Band 42	20M	QPSK	Full RB	М
LTE Band 42	Worst case from maximum power			М,
	LTE Band 42 LTE Band 42 LTE Band 42 LTE Band 42 LTE Band 42 LTE Band 42	Band         eg. 5M, 10M, 15M, 20M           LTE Band 42         5M, 10M, 15M, 20M           LTE Band 42         20M           LTE Band 42         5M, 10M, 15M, 20M           LTE Band 42         20M	Band         eg. 5M, 10M, 15M, 20M         eg. QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM           LTE Band 42         5M, 10M, 15M, 20M         QPSK           LTE Band 42         20M         QPSK	Band         IRB, Partial RB, Full RB           eg. 5M, 10M, 15M, 20M         eg. QPSK, 16QAM, 64QAM         1RB, Partial RB, Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         1RB, Full RB           LTE Band 42         20M         QPSK, 16QAM, 64QAM         Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         1RB, Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         1RB, Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         1RB, Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK, 16QAM, 64QAM         1RB, Full RB           LTE Band 42         5M, 10M, 15M, 20M         QPSK         1RB           LTE Band 42         20M         QPSK         Full RB

#### Note:

The device is investigated from 30MHz to 10 times of fundamental signal for radiated spurious emission test under different RB size/offset and modulations in exploratory test. Subsequently, only the worst case emissions are reported.

## 2.2 Connection Diagram of Test System



## 2.3 Support Unit used in test configuration and system

ltem	Equipment	Trade Name	Model No.	FCC ID	Data Cable	Power Cord
1.	Power Supply	GWINSTEK	PSS-2002	N/A	N/A	Unshielded, 1.8 m
2.	LTE Base Station	Anritsu	MT8820C	N/A	N/A	Unshielded, 1.8 m

## 2.4 Measurement Results Explanation Example

#### For all conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss between EUT conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level is exactly the EUT RF output level.

The spectrum analyzer offset is derived from RF cable loss.

Offset = RF cable loss.

Following shows an offset computation example with cable loss 8.72dB.

Example :

Offset(dB) = RF cable loss(dB).

= 8.72 (dB)



## 2.5 Frequency List of Low/Middle/High Channels

LTE Band 42 Channel and Frequency List										
BW [MHz]	Channel/Frequency(MHz)	Lowest	Middle	Highest						
20	Channel	42190	42590	42990						
20	Frequency	3460	3500	3540						
15	Channel	42165	42590	43015						
	Frequency	3457.5	3500	3542.5						
10	Channel	42140	42590	43040						
	Frequency	3455	3500	3545						
_	Channel	42115	42590	43065						
5	Frequency	3452.5	3500	3547.5						



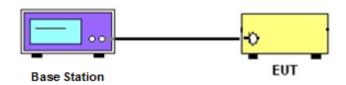
## 3 Conducted Test Items

### 3.1 Measuring Instruments

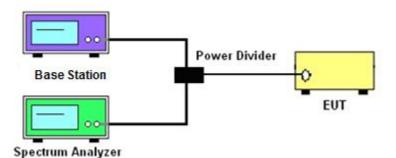
See list of measuring instruments of this test report.

## 3.2 Test Setup

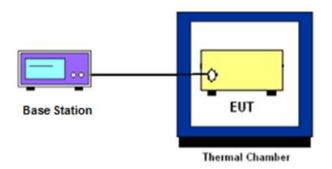
#### 3.2.1 Conducted Output Power



3.2.2 Peak-to-Average Ratio, Occupied / 26dB Bandwidth ,Band-Edge and Conducted Spurious Emission



3.2.3 Frequency Stability



## 3.3 Test Result of Conducted Test

Please refer to Appendix A.



### 3.4 Conducted Output Power Measurement

#### 3.4.1 Description of the Conducted Output Power Measurement

A base station simulator was used to establish communication with the EUT. Its parameters were set to transmit the maximum power on the EUT. The measured power in the radio frequency on the transmitter output terminals shall be reported.

#### 3.4.2 Test Procedures

- 1. The testing follows ANSI C63.26 Section 5.2
- 2. The transmitter output port was connected to the system simulator.
- 3. Set EUT at maximum power through the system simulator.
- 4. Select lowest, middle, and highest channels for each band and different modulation.
- 5. Measure and record the power level from the system simulator.



### 3.5 Peak-to-Average Ratio

#### 3.5.1 Description of the PAR Measurement

Power Complementary Cumulative Distribution Function (CCDF) curves provide a means for characterizing the power peaks of a digitally modulated signal on a statistical basis. A CCDF curve depicts the probability of the peak signal amplitude exceeding the average power level. Most contemporary measurement instrumentation include the capability to produce CCDF curves for an input signal provided that the instrument's resolution bandwidth can be set wide enough to accommodate the entire input signal bandwidth. In measuring transmissions in this band using an average power technique, the peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.

#### 3.5.2 Test Procedures

- 1. The testing follows ANSI C63.26 Section 5.2.3.4 (CCDF).
- 2. The EUT was connected to spectrum and system simulator via a power divider.
- 3. Set the CCDF (Complementary Cumulative Distribution Function) option in spectrum analyzer.
- 4. The highest RF powers were measured and recorded the maximum PAPR level associated with a probability of 0.1 %.
- 5. Record the deviation as Peak to Average Ratio.



### 3.6 EIRP

#### 3.6.1 Description of EIRP Limit

#### § 27.50 (k)(3)

Mobile devices are limited to 1Watt (30 dBm) EIRP. Mobile devices operating in these bands must employ a means for limiting power to the minimum necessary for successful communications

#### 3.6.2 Test Procedures

- 1. According to KDB 412172 D01 Power Approach,
- 2. EIRP =  $P_T$  +  $G_T$   $L_C$ , ERP = EIRP -2.15, where
  - $P_T$  = transmitter output power in dBm
  - $G_T$  = gain of the transmitting antenna in dBi
  - $L_{\text{C}}$  = signal attenuation in the connecting cable between the transmitter and antenna in dB



### 3.7 Occupied Bandwidth

#### 3.7.1 Description of Occupied Bandwidth Measurement

The occupied bandwidth is the width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean transmitted power.

The 26 dB emission bandwidth is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated 26 dB below the maximum in-band spectral density of the modulated signal. Spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth equal to approximately 1.0% of the emission bandwidth.

#### 3.7.2 Test Procedures

- 1. The testing follows ANSI C63.26 Section 5.4
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the spectrum analyzer shall be between two and five times the anticipated OBW.
- 4. The nominal resolution bandwidth (RBW) shall be in the range of 1 to 5 % of the anticipated OBW, and the VBW shall be at least 3 times the RBW.
- 5. Set the detection mode to peak, and the trace mode to max hold.
- Determine the reference value: Set the EUT to transmit a modulated signal. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace. (this is the reference value)
- 7. Determine the "-26 dB down amplitude" as equal to (Reference Value X).
- 8. Place two markers, one at the lowest and the other at the highest frequency of the envelope of the spectral display such that each marker is at or slightly below the "-X dB down amplitude" determined in step 6. If a marker is below this "-X dB down amplitude" value it shall be placed as close as possible to this value. The OBW is the positive frequency difference between the two markers.
- 9. Use the 99 % power bandwidth function of the spectrum analyzer and report the measured bandwidth.



### 3.8 Conducted Band Edge Measurement

#### 3.8.1 Description of Conducted Band Edge Measurement

#### § 27.53 (n)(2)

For mobile operations in the 3450-3550 MHz band, the conducted power of any emission outside the licensee's authorized bandwidth shall not exceed -13 dBm/MHz.

Compliance with this paragraph is based on the use of measurement instrumentation employing a resolution bandwidth of 1 megahertz or greater. However, in the 1 megahertz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed, but limited to a maximum of 200 kHz. In the bands between 1 and 5 MHz removed from the licensee's frequency block, the minimum resolution bandwidth for the measurement shall be 500 kHz.

#### 3.8.2 Test Procedures

- 1. The testing follows ANSI C63.26 section 5.7
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- 3. The band edges of low and high channels for the highest RF powers were measured.
- 4. Set RBW ≥ 1% EBW but limited to a maximum of 200 kHz in the 1MHz band immediately outside and adjacent to the band edge.
- 5. Beyond the 1 MHz and 5 MHz removed from the band edge, set RBW  $\geq$  500KHz.
- 6. Beyond the 5 MHz removed from the band edge, set RBW = 1MHz.
- 7. Set spectrum analyzer with RMS detector.
- 8. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.
- 9. Checked that all the results comply with the emission limit line.



### **3.9 Conducted Spurious Emission Measurement**

#### 3.9.1 Description of Conducted Spurious Emission Measurement

The power of any emission outside of the authorized operating frequency ranges shall not exceed -13 dBm/MHz.

It is measured by means of a calibrated spectrum analyzer and scanned from 9 kHz up to a frequency including its 10<sup>th</sup> harmonic.

#### 3.9.2 Test Procedures

- 1. The testing follows ANSI C63.26 section 5.7
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.
- 4. The middle channel for the highest RF power within the transmitting frequency was measured.
- 5. The conducted spurious emission for the whole frequency range was taken.
- 6. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz.
- 7. Set spectrum analyzer with RMS detector.
- 8. Taking the record of maximum spurious emission.
- 9. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.
- 10. Checked that all the results comply with the emission limit line.



### 3.10 Frequency Stability Measurement

#### 3.10.1 Description of Frequency Stability Measurement

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block.

#### 3.10.2 Test Procedures for Temperature Variation

- 1. The testing follows ANSI C63.26 section 5.6.4
- 2. The EUT was set up in the thermal chamber and connected with the system simulator.
- 3. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute.
- 4. With power OFF, the temperature was raised in 10°C step up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute.

#### 3.10.3 Test Procedures for Voltage Variation

- 1. The testing follows ANSI C63.26 section 5.6.5.
- 2. The EUT was placed in a temperature chamber at 20±5°C and connected with the system simulator.
- 3. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value for other than hand carried battery equipment.
- 4. For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.
- 5. The variation in frequency was measured for the worst case.



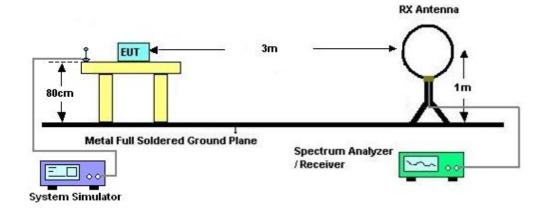
## 4 Radiated Test Items

### 4.1 Measuring Instruments

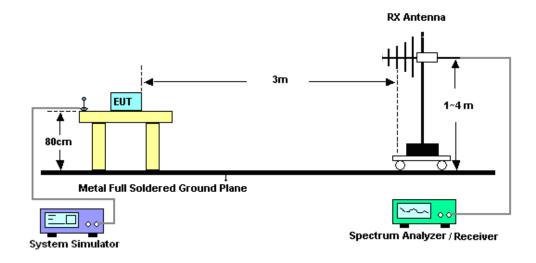
See list of measuring instruments of this test report.

### 4.2 Test Setup

#### 4.2.1 For radiated test below 30MHz

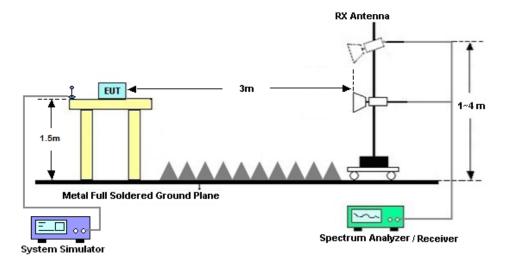


### 4.2.2 For radiated test from 30MHz to 1GHz





#### 4.2.3 For radiated test above 1GHz



## 4.3 Test Result of Radiated Test

The low frequency, which started from 9 kHz to 30MHz, was pre-scanned and the result which was 20dB lower than the limit line was not reported.

Please refer to Appendix B.



### 4.4 Radiated Spurious Emission Measurement

#### 4.4.1 Description of Radiated Spurious Emission

The radiated spurious emission was measured by substitution method according to ANSI/TIA-603-E.

The power of any emission outside of the authorized operating frequency ranges shall not exceed -13 dBm/MHz.

The spectrum is scanned from 30 MHz up to a frequency including its 10th harmonic.

#### 4.4.2 Test Procedures

- 1. The testing follows ANSI C63.26 Section 5.5
- 2. The EUT was placed on a turntable with 0.8 meter height for frequency below 1GHz and 1.5 meter height for frequency above 1GHz respectively above ground.
- 3. The EUT was set 3 meters from the receiving antenna mounted on the antenna tower.
- 4. The table was rotated 360 degrees to determine the position of the highest spurious emission.
- 5. The height of the receiving antenna is varied between 1m to 4m to search the maximum spurious emission for both horizontal and vertical polarizations.
- 6. During the measurement, the system simulator parameters were set to force the EUT transmitting at maximum output power.
- 7. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.
- 8. A horn antenna was substituted in place of the EUT and was driven by a signal generator.
- 9. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission.

EIRP (dBm) = S.G. Power – Tx Cable Loss + Tx Antenna Gain ERP (dBm) = EIRP - 2.15

10. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.



## 5 List of Measuring Equipment

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Test Date	Due Date	Remark
Spectrum Analyzer	R&S	FSV40	101040	10Hz~40GHz	Oct. 12, 2022	Jun. 27, 2023~ Jun. 28, 2023	Oct. 11, 2023	Conducted (TH01-KS)
Power divider	STI	STI08-0055	-	0.5~40GHz	/	Jun. 27, 2023~ Jun. 28, 2023	/	Conducted (TH01-KS)
Temperature &hu midity chamber	Hongzhan	LP-150U	H201401144 0	-40~+150°C 20%~95%RH	Jul. 15, 2022	Jun. 27, 2023~ Jun. 28, 2023	Jul. 14, 2023	Conducted (TH01-KS)
EXA Spectrum Analyzer	Keysight	N9010B	MY5747107 9	10Hz-44G,MAX 30dB	Oct. 12, 2022	Jun. 25, 2023	Oct. 11, 2023	Radiation (03CH04-KS)
Loop Antenna	R&S	HFH2-Z2	100321	9kHz~30MHz	Oct. 16, 2022	Jun. 25, 2023	Oct. 15, 2023	Radiation (03CH04-KS)
Bilog Antenna	TeseQ	CBL6111D	49922	30MHz-1GHz	Apr. 09, 2023	Jun. 25, 2023	Apr. 08, 2024	Radiation (03CH04-KS)
Horn Antenna	Schwarzbeck	BBHA9120 D	1284	1GHz~18GHz	Oct. 16, 2022	Jun. 25, 2023	Oct. 15, 2023	Radiation (03CH04-KS)
SHF-EHF Horn	Com-power	AH-840	101070	18GHz~40GHz	Jan. 08, 2023	Jun. 25, 2023	Jan. 07, 2024	Radiation (03CH04-KS)
Amplifier	SONOMA	310N	380827	9KHz-1GHz	Jul. 11, 2022	Jun. 25, 2023	Jul. 10, 2023	Radiation (03CH04-KS)
Amplifier	MITEQ	EM18G40G GA	060728	18~40GHz	Jan. 05, 2023	Jun. 25, 2023	Jan. 04, 2024	Radiation (03CH04-KS)
high gain Amplifier	EM	EM01G18G A	060840	1Ghz-18Ghz	Oct. 12, 2022	Jun. 25, 2023	Oct. 11, 2023	Radiation (03CH04-KS)
Amplifier	Agilent	8449B	3008A02370	1Ghz-18Ghz	Oct. 12, 2022	Jun. 25, 2023	Oct. 11, 2023	Radiation (03CH04-KS)
AC Power Source	Chroma	61601	F104090004	N/A	NCR	Jun. 25, 2023	NCR	Radiation (03CH04-KS)
Turn Table	ChamPro	EM 1000-T	060762-T	0~360 degree	NCR	Jun. 25, 2023	NCR	Radiation (03CH04-KS)
Antenna Mast	ChamPro	EM 1000-A	060762-A	1 m~4 m	NCR	Jun. 25, 2023	NCR	Radiation (03CH04-KS)

NCR: No Calibration Required

## 6 Measurement Uncertainty

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI 63.26-2015. All the measurement uncertainty value were shown with a coverage K=2 to indicate 95% level of confidence. The measurement data show herein meets or exceeds the CISPR measurement uncertainty values specified in CISPR 16-4-2 and can be compared directly to specified limit to determine compliance.

#### Uncertainty of Conducted Measurement

Test Item	Uncertainty		
Conducted Power	±0.46 dB		
Conducted Emissions	±2.26 dB		
Occupied Channel Bandwidth	±0.1 %		

#### Uncertainty of Radiated Emission Measurement (30 MHz ~ 1000 MHz)

Confidence of 95% (U = 2Uc(y)) 3.82dB	Measuring Uncertainty for a Level of Confidence of 95% (U = 2Uc(y))	3.82dB
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#### Uncertainty of Radiated Emission Measurement (1 GHz ~ 18 GHz)

Measuring Uncertainty for a Level of Confidence of 95% (U = 2Uc(y))	3.56dB
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#### Uncertainty of Radiated Emission Measurement (18 GHz ~ 40 GHz)

Confidence of 95% (U = 2Uc(y)) 3.54dB	Measuring Uncertainty for a Level of Confidence of 95% (U = 2Uc(v))	3.54dB
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----- THE END ------



## Appendix A. Test Results of Conducted Test

Test Engineer :	Simle Wang	Temperature :	22~23°C	
		Relative Humidity :	40~42%	

## Conducted Output Power(Average power) and EIRP

BW [MHz]	Modulation	RB Size	RB Offset	Power Low Ch. / Freq.	Power Middle Ch. / Freq.	Power High Ch. / Freq.	EIRP(W)		
	Cha	nnel		42190	42590	42990			
Frequency (MHz)			3460	3500	3540	L	М	Н	
20	QPSK	1	0	22.26	22.33	22.21	0.0701	0.0713	0.0693
20	QPSK	1	99	22.10	22.20	22.06	0.0676	0.0692	0.0670
20	QPSK	100	0	21.24	21.33	21.28	0.0555	0.0566	0.0560
20	16QAM	1	0	21.15	21.30	21.24	0.0543	0.0562	0.0555
20	64QAM	1	0	20.06	20.13	20.01	0.0423	0.0430	0.0418
Channel			42165	42590	43015	EIRP(W)			
Frequency (MHz)			3457.5	3500	3542.5	L	М	Н	
15	QPSK	1	0	22.20	22.28	22.18	0.0692	0.0705	0.0689
15	16QAM	1	0	21.10	21.21	21.14	0.0537	0.0551	0.0542
	Channel				42590	43040	EIRP(W)		
	Frequence	cy (MHz)		3455	3500	3545	L	М	Н
10	QPSK	1	0	22.19	22.21	22.14	0.0690	0.0693	0.0682
10	16QAM	1	0	21.03	21.26	21.18	0.0528	0.0557	0.0547
	Cha	nnel		42115	42590	43065		EIRP(W)	
	Frequence	cy (MHz)		3452.5	3500	3547.5	L	М	Н
5	QPSK	1	0	22.14	22.29	22.09	0.0682	0.0706	0.0675
5	16QAM	1	0	21.08	21.21	21.18	0.0535	0.0551	0.0547

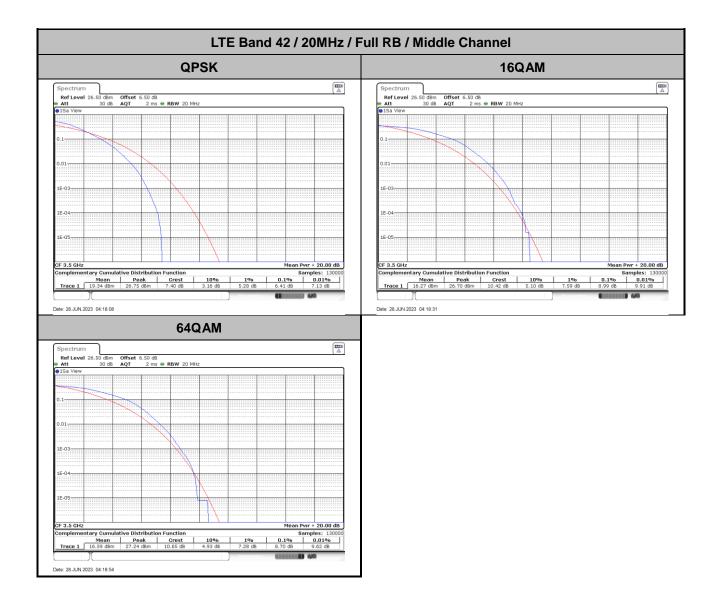


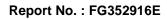
## LTE Band 42

## Peak-to-Average Ratio

Mode							
Mod.	QPSK	QPSK 16QAM - I					
RB Size		Result					
Middle CH	6.41	8.99	8.70	-	PASS		



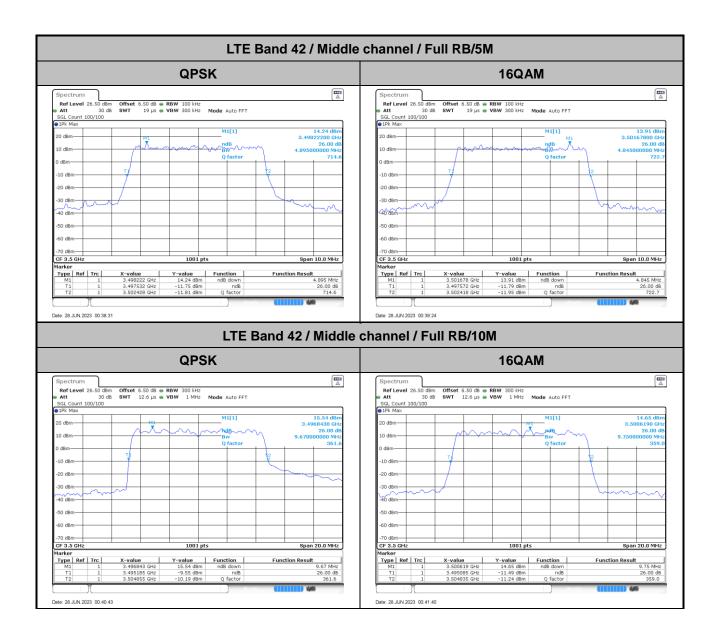




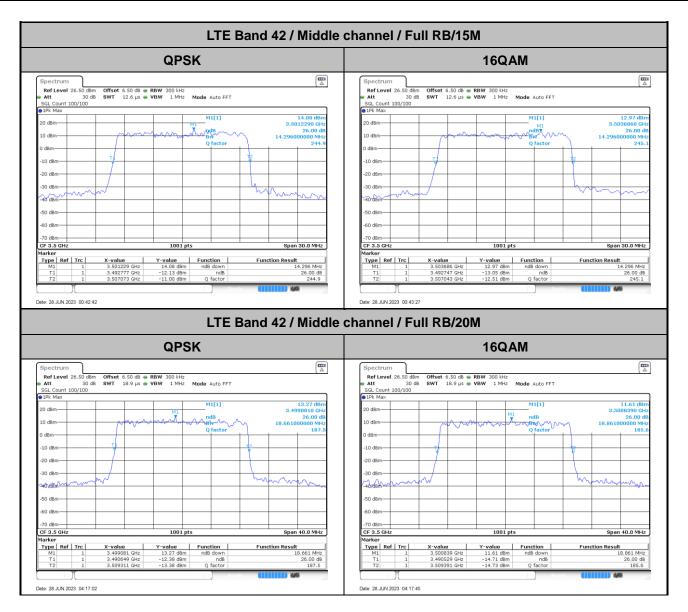


## 26dB Bandwidth

Mode		LTE Band 42 : 26dB BW(MHz)							
BW	51	ИHz	10MHz		15MHz		20MHz		
Mod.	QPSK	16QAM	QPSK	16QAM	QPSK	16QAM	QPSK	16QAM	
Middle CH	4.90	4.85	9.67	9.75	14.30	14.30	18.66	18.86	



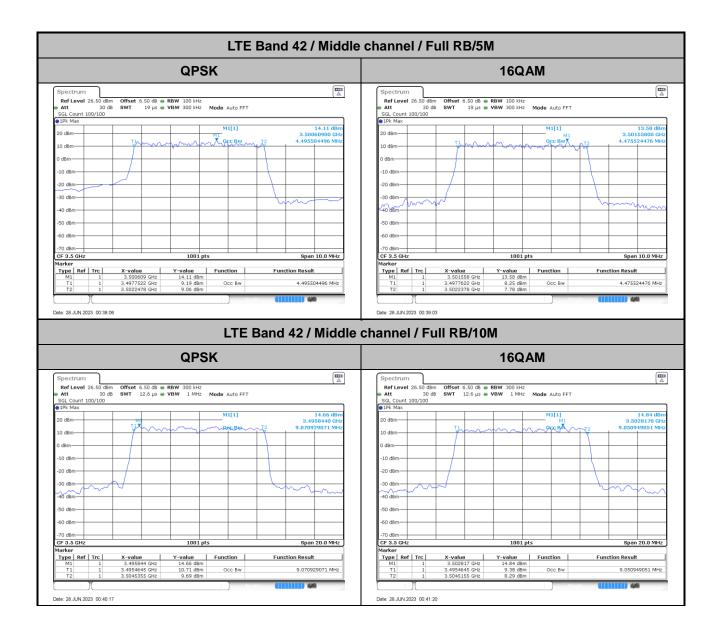




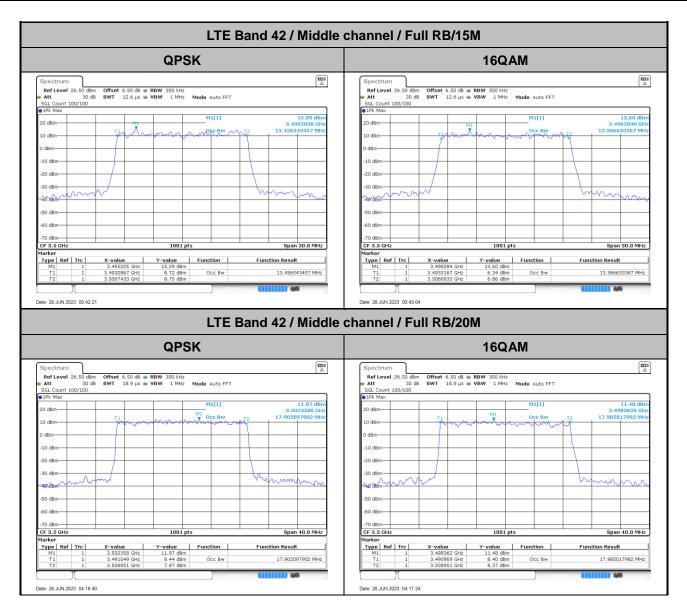


## **Occupied Bandwidth**

Mode	LTE Band 42 : 99%OBW(MHz)							
BW	5N	IHz	10MHz		15MHz		20MHz	
Mod.	QPSK	16QAM	QPSK	16QAM	QPSK	16QAM	QPSK	16QAM
Middle CH	4.50	4.48	9.07	9.05	13.46	13.37	17.90	17.98

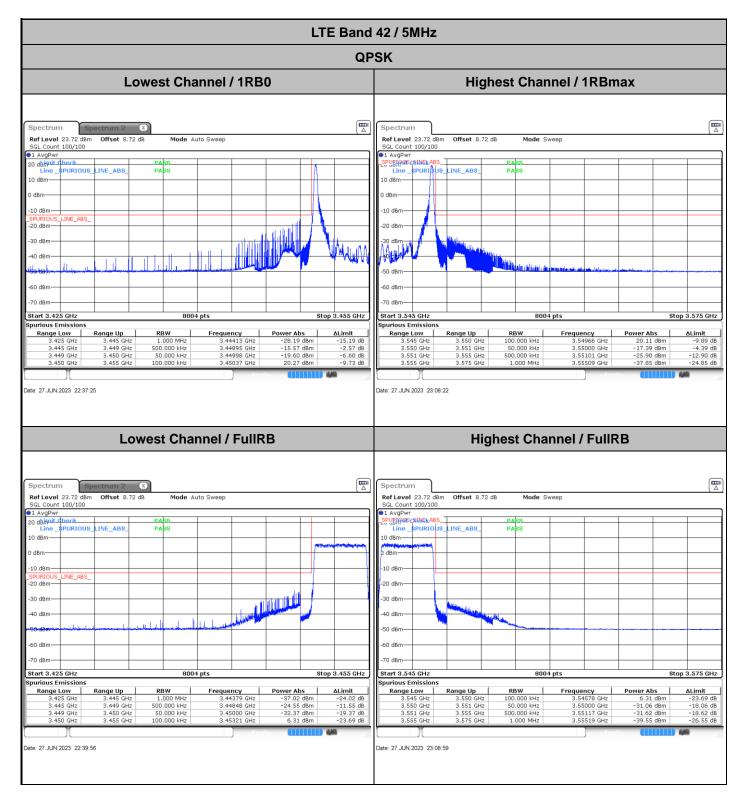




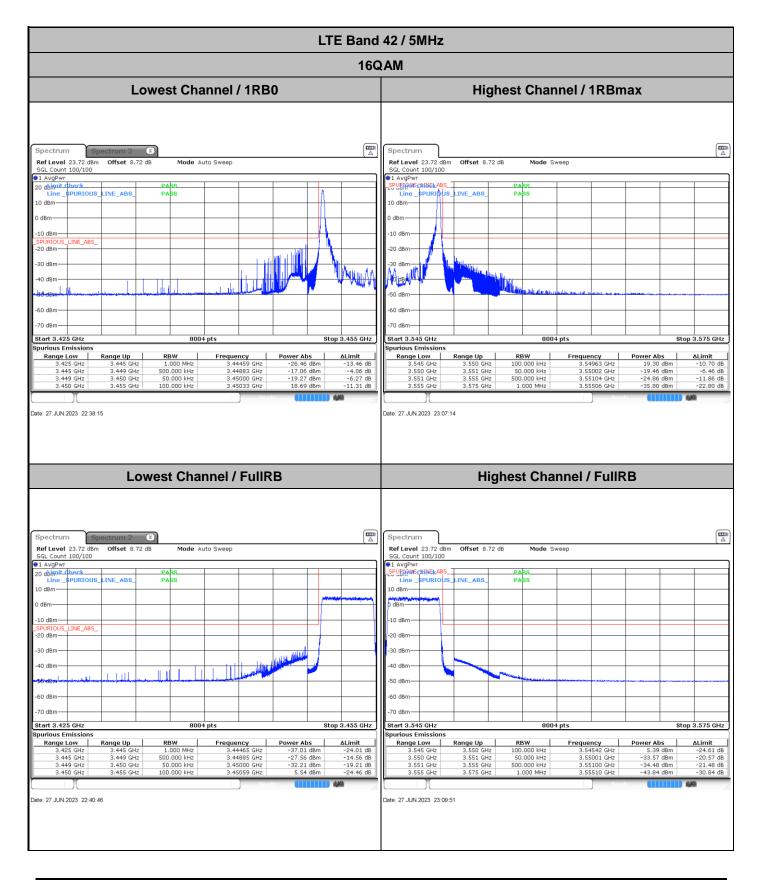




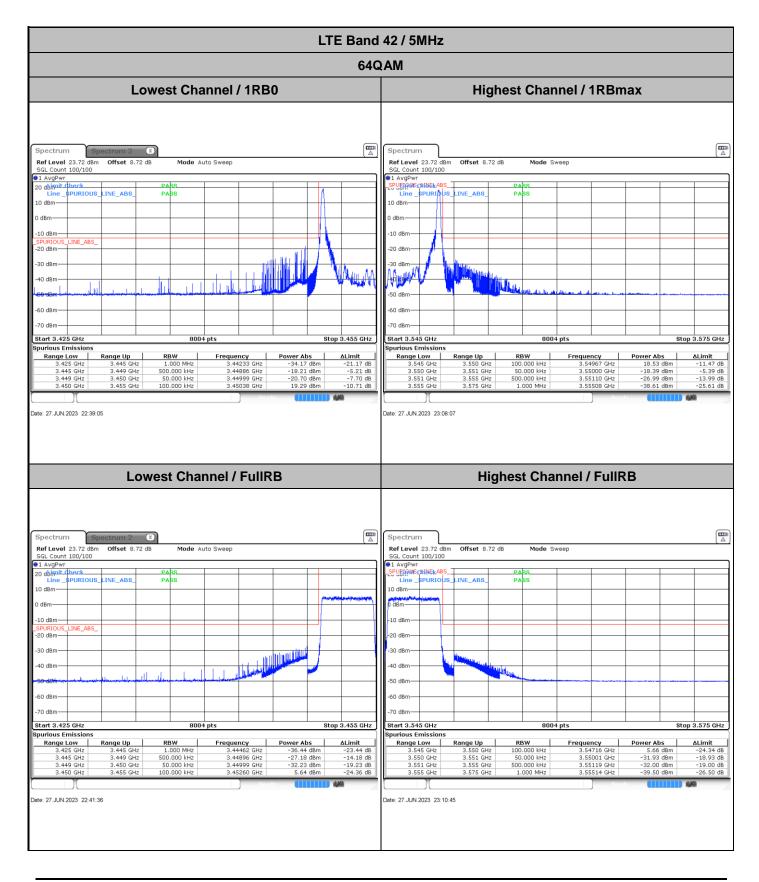
## Conducted Band Edge



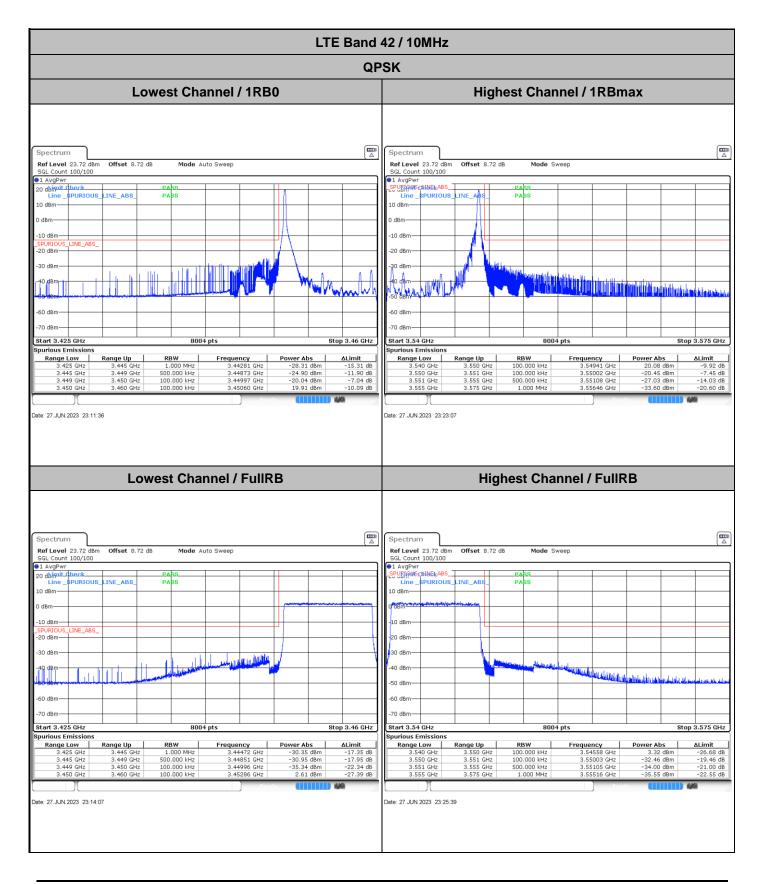




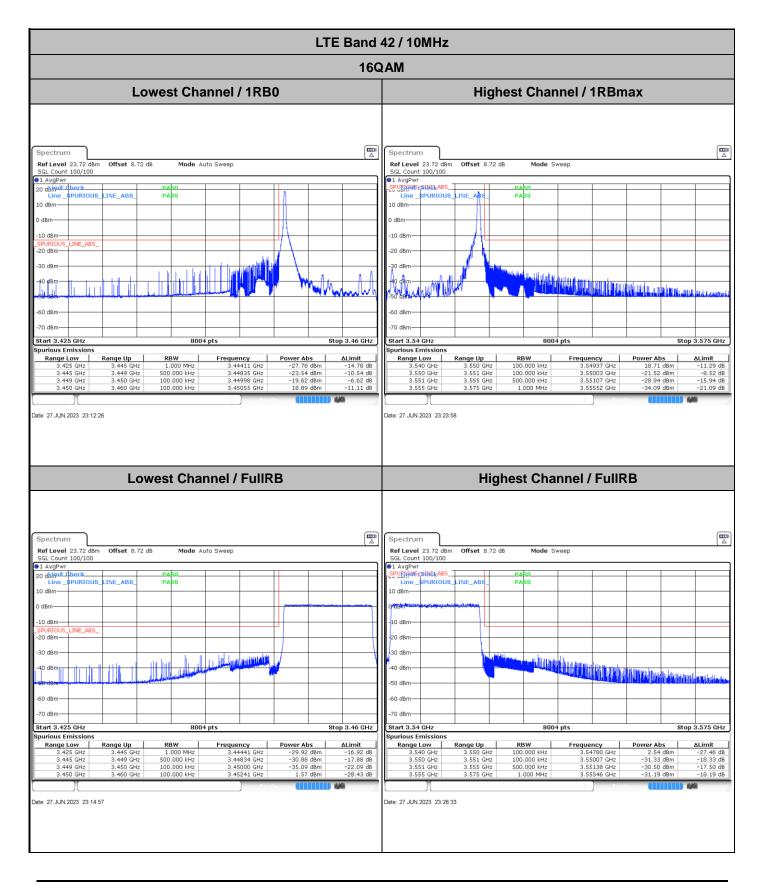




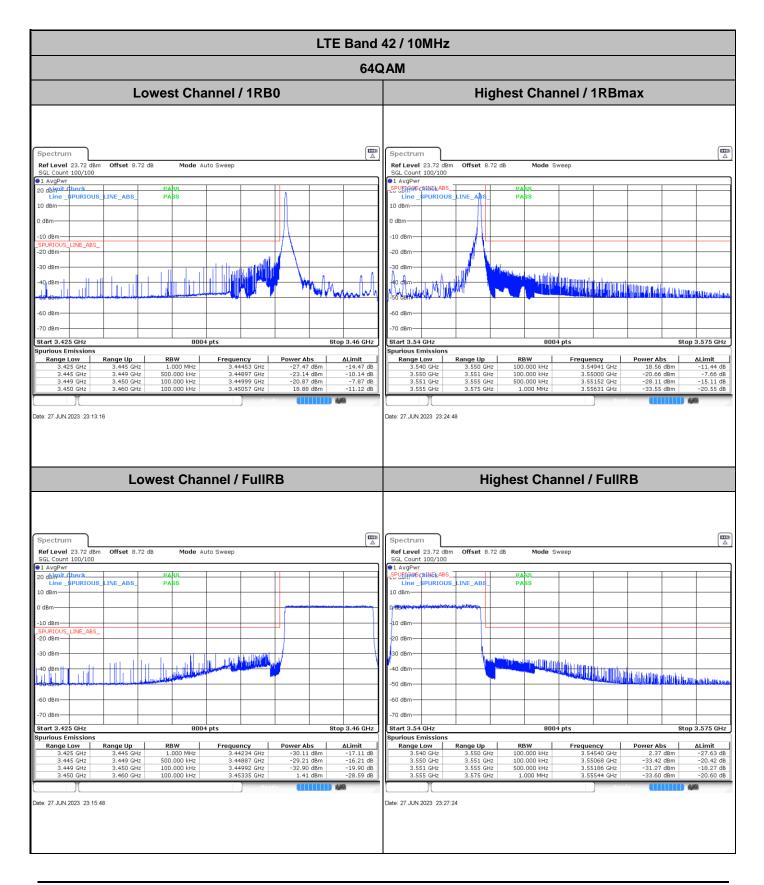




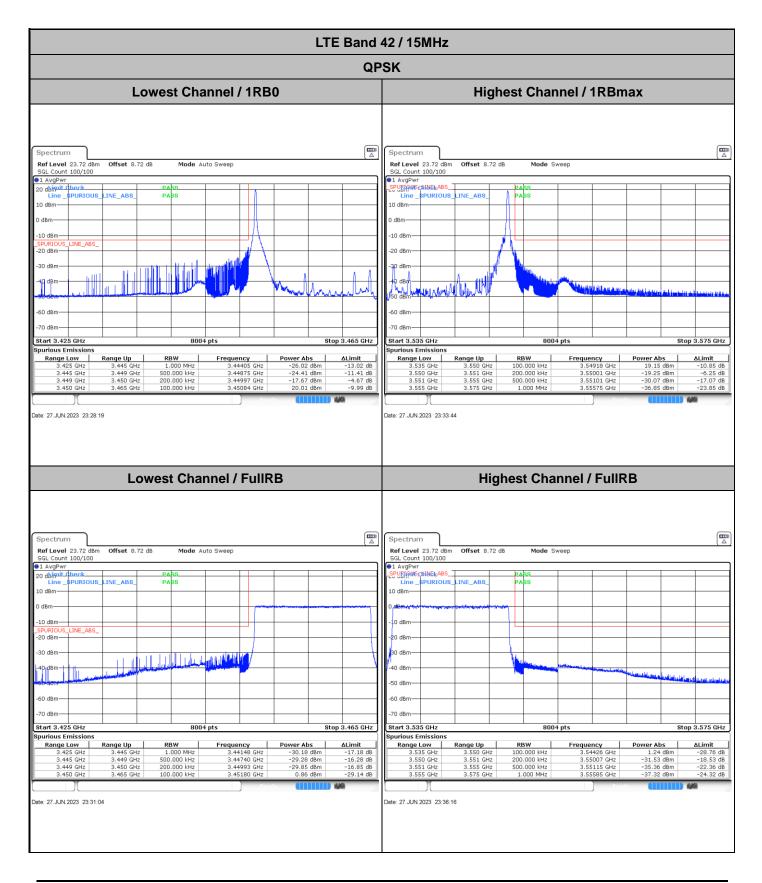




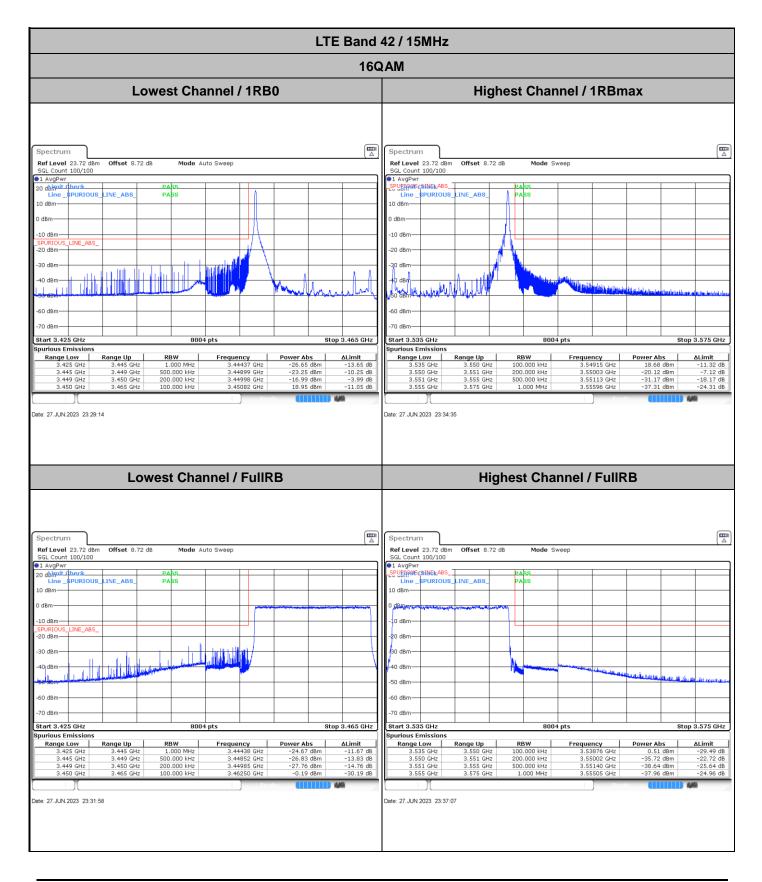




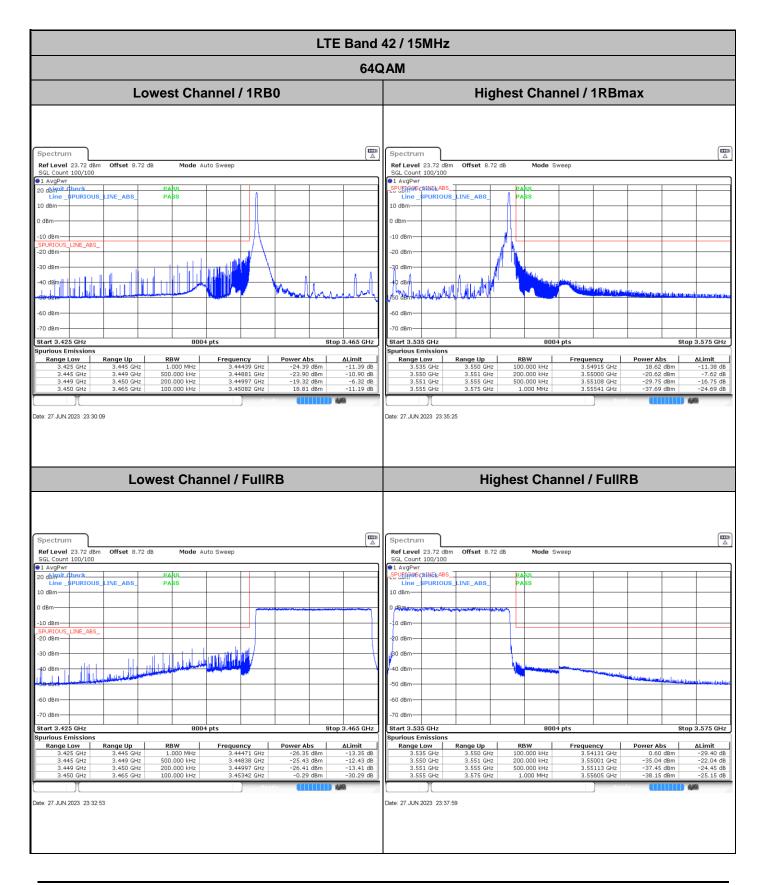




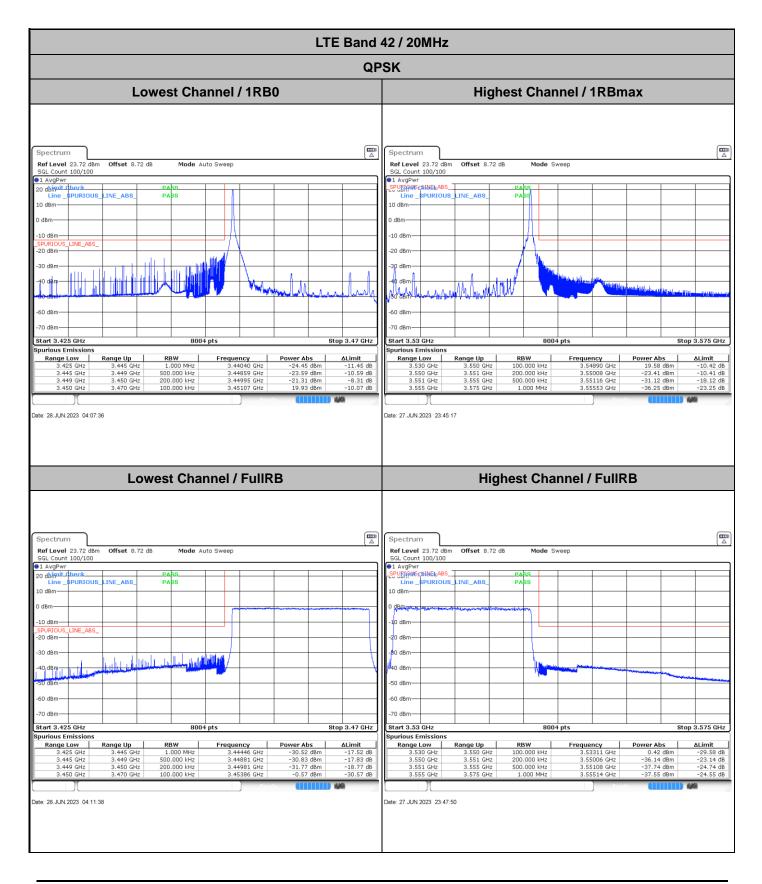




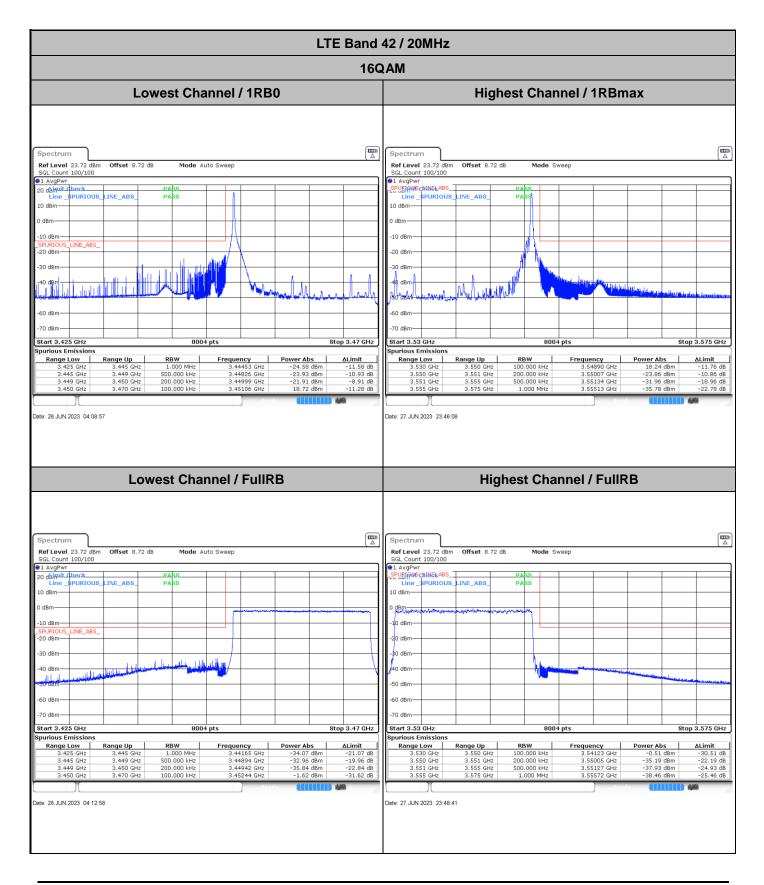




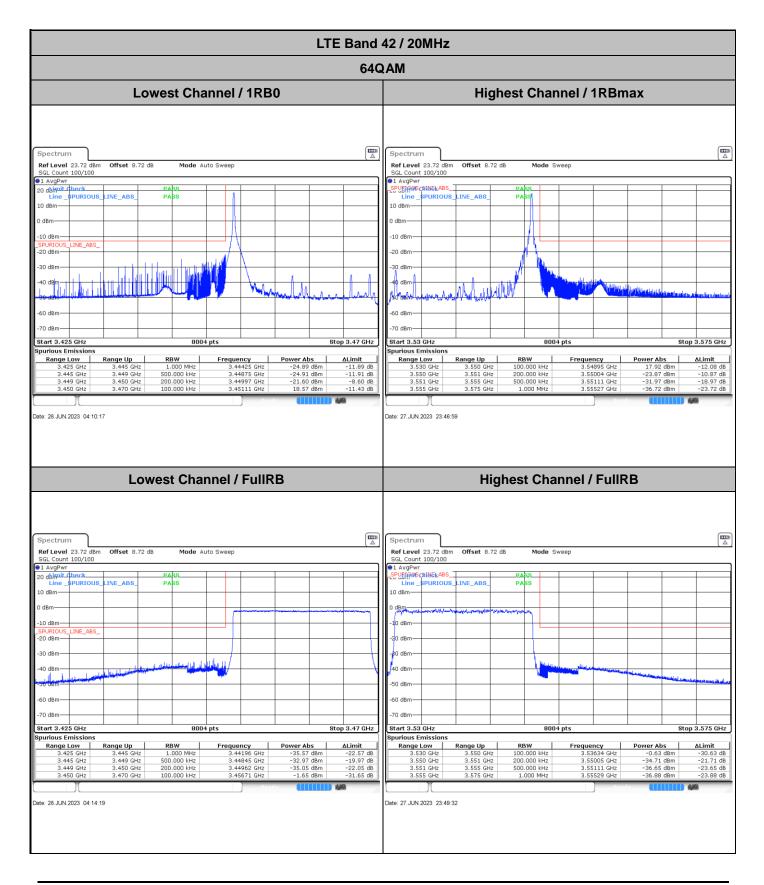






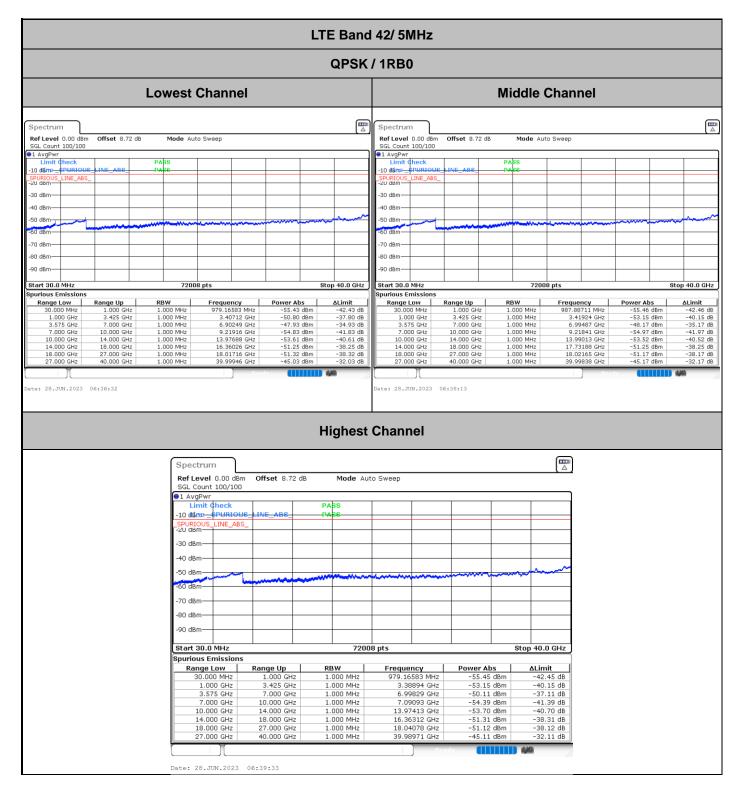




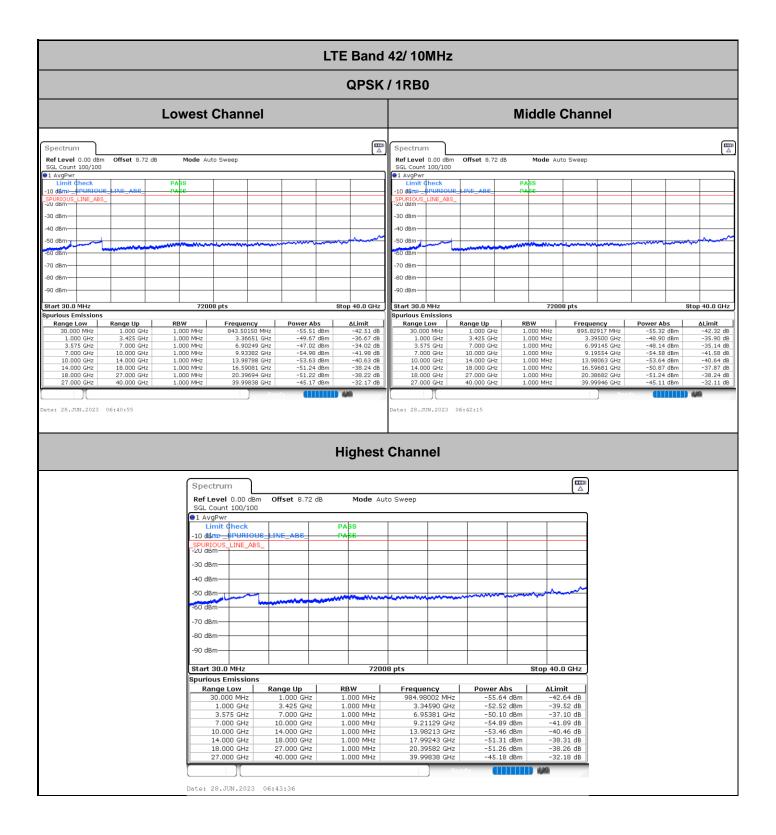




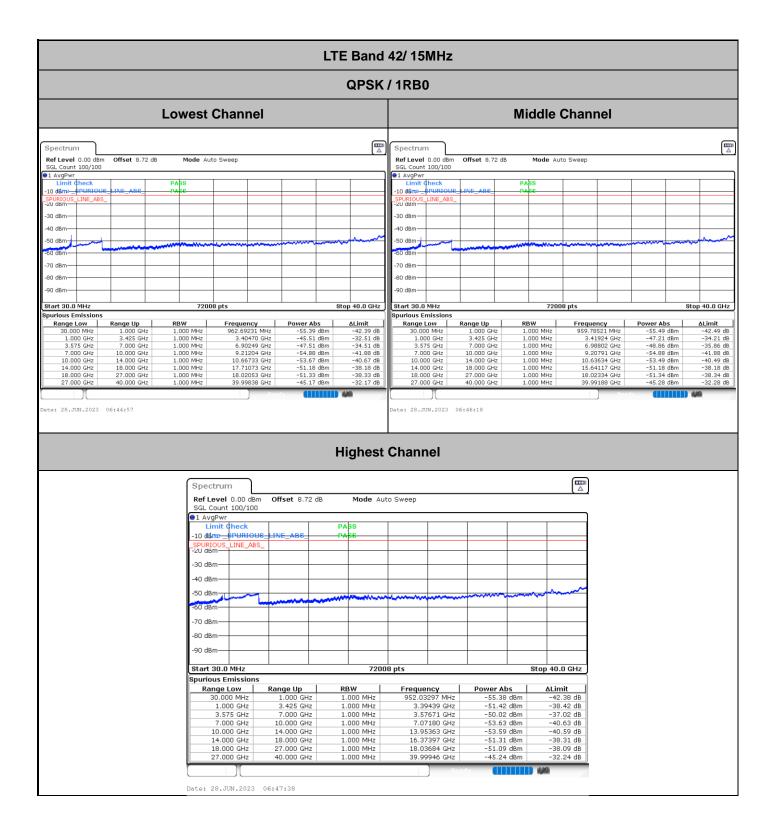
### **Conducted Spurious Emission**



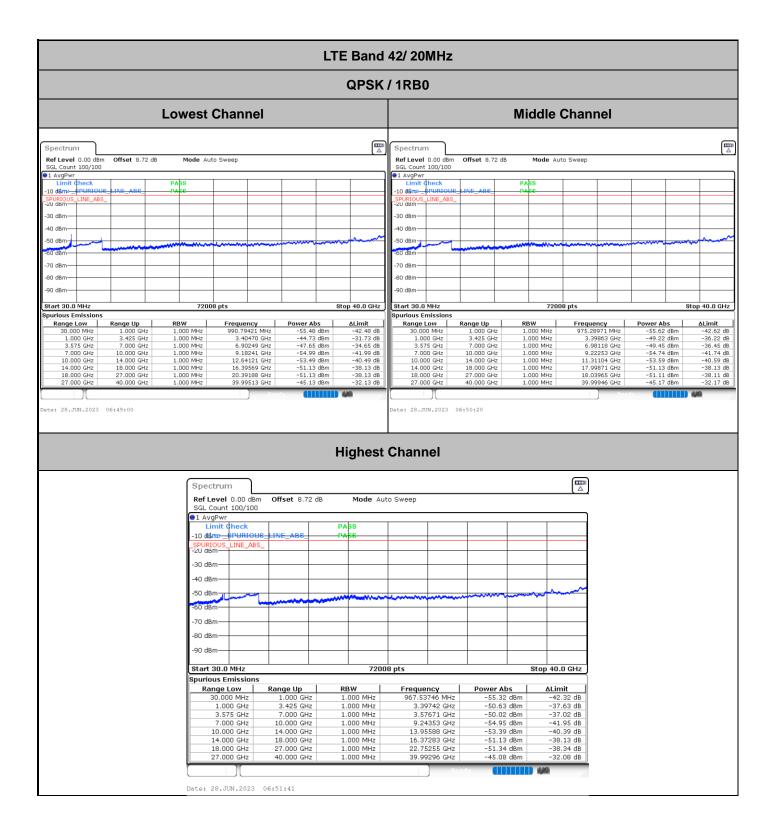














### Frequency Stability

Test Conditions		LTE Band 42 (QPSK) / Middle Channel		
Temperature (°C)		BW 5MHz	Note 2.	
	Voltage (Volt)	Deviation (ppm)	Result	
50	Normal Voltage	0.0021		
40	Normal Voltage	0.0012		
30	Normal Voltage	0.0016		
20(Ref.)	Normal Voltage	0.0000		
10	Normal Voltage	0.0011		
0	Normal Voltage	0.0008		
-10	Normal Voltage	0.0019	PASS	
-20	Normal Voltage	0.0023		
-30	Normal Voltage	0.0018		
20	Maximum Voltage	0.0019		
20	Normal Voltage	0.0005		
20	Battery End Point	0.0013		

#### Note:

- 1. Normal Voltage =3.91V ; Battery End Point (BEP) =3.6V ; Maximum Voltage =4.45V
- 2. Note: The frequency fundamental emissions stay within the authorized frequency block.



# Appendix B. Test Results of Radiated Test

# **Radiated Spurious Emission**

LTE Band 42 / 20MHz / QPSK										
Channel	Frequency (MHz)	EIRP ( dBm )	Limit ( dBm )	Over Limit ( dB )	S.G. Power ( dBm )	TX Cable loss ( dB )	TX Antenna Gain (dBi)	Polarization (H/V)		
Middle	6984	-63.44	-13	-50.44	-73.65	3.03	13.24	Н		
	10476	-61.95	-13	-48.95	-71.40	3.56	13.01	Н		
	13962	-60.23	-13	-47.23	-69.75	3.92	13.44	Н		
	6984	-63.04	-13	-50.04	-73.25	3.03	13.24	V		
	10476	-62.18	-13	-49.18	-71.63	3.56	13.01	V		
	13962	-60.27	-13	-47.27	-69.79	3.92	13.44	V		

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.